Se	arch	Note	S

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/770,459	TAKEMOTO ET	AL.
Examiner	Art Unit	
John L. Goff	1733	

SEARCHED			
Class	Subclass	Date	Examiner
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156	85,307.3, 307.7	4/10/2006	JLG
248	205.4	4/10/2006	JLG
347	40	4/10/2006	JLG
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	4/10/2006	JLG
Inventor Search .	4/10/2006	JLG
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